

Search Notes

Application/Control No.

10/766,299

Examiner

Y. J. Han

Applicant(s)/Patent under
Reexamination

ZVEREV ET AL.

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
323	222		
	271		
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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PLUS	1/25/2006	/JH/